MIL-PRF-38534 AND 38535 CERTIFIED FACILITY

M.S.KENNEDY CORP. 600V/200A THREE PHASE BRIDGE 4854 PEM WITH BRAKE

FEATURES:

- Replaces MSK4851 with Lower Conduction Loss
- Full Three Phase Bridge Configuration with SCR/IGBT Brake
- 600V Rated Voltage
- · 200A Continuous Output Current
- Internal Zener Clamps on Gates
- Encapsulation Provides Near Hermetic Performance
- HI-REL Screening Available (Modified 38534)
- · Light Weight Domed AlSiC Baseplate
- Robust Mechanical Design for Hi-Rel Applications
- Ultra-Low Inductance Internal Layout
- + Withstands 96 Hours HAST and Thermal Cycling (-55 $^{\circ}\text{C}$ to $\,+\,125\,^{\circ}\text{C}$)

DESCRIPTION:

The MSK4854 is one of a family of plastic encapsulated modules (PEM) developed specifically for use in military, aerospace and other severe environment applications. The Three Phase Bridge configuration along with the SCR/IGBT brake circuit and 600 volt/200 amp rating make it ideal for use in high current motor drive and inverter applications. The Aluminum Silicon Carbide (AISiC) baseplate offers superior flatness and light weight; far better than the copper or copper alloys found in most high power plastic modules. The high thermal conductivity materials used to construct the MSK4854 allow high power outputs at elevated baseplate temperatures.

EQUIVALENT SCHEMATIC



TYPICAL APPLICATIONS

- Motor Drives
- Inverters

ABSOLUTE MAXIMUM RATING

Vce	Collector to Emitter Voltage
Vge	Gate to Emitter Voltage
Ιουτ	Current (Continuous)
IOUTP	Current Pulsed (1mS)
VCASE	Case Isolation Voltage

(8)

Storage Temperature Range ⁽⁹⁾ . -55°C to + 125°C Tst

- ΤJ
- Тс Case Operating Temperature Range

ELECTRICAL SPECIFICATIONS

Paramatar (6)	Test Conditions	Group A	M\$K4854H			M\$K4854			Unite
	rest conditions	Subgroup	Min.	Typ.	Max.	Min.	Typ.	Max.	Onits
		1	-	1.80V	2.20V	-	1.80V	2.30V	V
Collector-Emitter Saturation Voltage	e IC=200A, VGE=15V	2	-	2.00V	2.40V	-	-	-	V
		3	-	1.60V	2.10V	-	-	-	V
		1	-	0.5	350	-	0.5	400	uA
Collector-Emitter Leakage Current	VCE = 600V, VGE = 0V	2	-	650	1700	-	-	-	uA
	IC=60mA, VCE=VGE	1	5.0	6.0	6.5	4.8	6.0	6.8	V
Gate Threshold Voltage		2	4.0	5.0	6.5	-	-	-	V
		3	5.0	6.5	7.5	-	-	-	V
	$VCE = OV, VGE = \pm 15V$	1	-	0.1	10	-	0.1	10	uA
Gate Leakage Current		2	-	0.6	10	-	-	-	uA
		3	-	0.1	10	-	-	-	μA
	IC = 200A	1	-	1.70V	2.20V	-	1.70V	2.30V	V
Diode Forward Voltage		2	-	1.40V	2.20V	-	-	-	V
		3	-	1.80V	2.60V	-	-	-	V
	VRRM = 600V	1	-	0.01	15	-	0.01	18	mΑ
SCR Reverse Leakage		2	-	0.01	15	-	-	-	mA
		3	-	0.01	15	-	-	-	mA
		1	-	1.0	1.35	-	1.0	1.4	V
SCR On Voltage	IF = 100A	2	-	1.0	1.35	-	-	-	V
		3	-	1.0	1.35	-	-	-	V
		1	-	100	300	-	100	325	mΑ
SCR Holding Current		2	-	90	300	-	-	-	mA
		3	-	110	300	-	-	-	mA
Regen Diode Forward Voltage	IF = 50A	1	-	1.3	2.4	-	1.3	2.5	V
Total Gate Charge ①	V=300V, IC=200A	4	-	1.0	1.5	-	1.0	1.6	uC
V = 300V, IC = 2	200A, $RG = 5\Omega$, $VGE = -7/+15V$	4	-	6	-	-	6	-	mJ
V = 300V, Ic = 7	$V = 300V$, IC = 100A, RG = 5 Ω , VGE = -7/ + 15V			3	6	-	3	7	mJ
V = 300V, IC = 2	$00A, RG = 10\Omega, VGE = -7/+15V$	4	-	9	-	-	9	-	mJ
V = 300V, IC = 1	$V = 300V$, IC = 100A, RG = 10 Ω , VGE = -7/+15V			5	8	-	5	9	mJ
Diada Payaraa Paaayary Tima (1)	IE = 200, di/dt = 2770A/uS	4	-	56	-	-	56	-	nS
	IE = 100, di/dt = 2770 A/uS	4	-	47	-	-	47	-	nS
Diode Beverse Epergery(1)	IE = 200, $di/dt = 2770A/uS$	4	-	0.5	-	-	0.5	-	mJ
	IE = 100, di/dt = 2770A/uS	4	-	0.4	2.4	-	0.4	-	mJ
Thormal Resistance (1)	IGBT @ TJ = 125°C	-	-	0.21	0.26	-	0.21	0.26	°C/W
	DIODE @ TJ = 125°C	-	-	0.17	0.21	-	0.17	0.21	°C/W

NOTES:

- Guaranteed by design but not tested. Typical parameters are representative of actual device performance but are for reference only. 10346 Industrial grade devices shall be tested to subgroup 1 unless otherwise specified.
- HI-REL grade devices ("H" suffix) shall be 100% tested to subgroups 1, 2 and sample tested to subgroup 3.
- Subgroup 4 testing available upon request.

Subgroup 1, 4 $TA = +25^{\circ}C$

 $TA = +125^{\circ}C$ 2

3 $T_A = -55^{\circ}C$

- All specifications apply to both the upper and lower sections of the half bridge.
- 6
 7 $V_{GE} = 15V$ unless otherwise specified.
- 8 9 Continuous operation at or above absolute maximum ratings may adversly effect the device performance and/or life cycle.
- Internal solder reflow temperature is 180°C, do not exceed.

THERMAL CALCULATIONS

Power dissipation and maximum allowable temperature rise involve many variables working together. Collector current, PWM duty cycle and switching frequency all factor into power dissipation. DC losses or "ON-TIME" losses are simply VcE(SAT) x Collector Current x PWM duty cycle. For the MSK4854, VcE(SAT) = 2.2V max., and at 200 amps and a PWM duty cycle of 30%, DC losses equal 132 watts. Switching losses, in milli-joules, vary proportionally with switching frequency. The MSK4854 typical switching losses at VcE = 300V and IcE = 200A are about 15mJ, which is simply the sum of the turn-on switching loss and the turn-off switching loss. Multiplying the switching frequency times the switching losses will result in a power dissipation number for switching. The MSK4854, at 15KHz, will exhibit switching power dissipation of 225 watts. The total losses are the sum of DC losses plus switching losses, or in this case, 357 watts total. 357 watts x 0.26°C/W thermal resistance equals 92.8 degrees of temperature rise between the case and the junction. Subtracting 93°C from the maximum junction temperature of 150°C equals 57°C maximum case temperature for this

example.

VCE(SAT) x IC x PWM duty cycle = 2.2V x 200 amps x 30% = 132 watts DC losses

Turn-on switching loss + Turn-off switching loss = Total switching losses = 6 + 9 = 15mJ

Total switching loss x PWM frequency = Total switching power dissipation = 15mJ x 15KHz = 225 watts

Total power dissipation = DC losses + switching losses = 132 + 225 = 357 watts

Junction temperature rise above case = Total power dissipation x thermal resistance

357 watts x 0.26°C/W = 92.8°C temperature rise above case

Maximum junction temperature - junction temperature rise = maximum baseplate temperature

 $150^{\circ}C - 93^{\circ}C = 57^{\circ}C$













8548-123 Rev. E 5/14

OPERATION	INDUSTRIAL	H SUFFIX		
QUALIFICATION (MODIFIED)	NO	YES		
ELEMENT EVALUATION	NO	YES		
CLEAN ROOM PROCESSING	YES	YES		
NON DESTRUCT BOND PULL SAMPLE	YES	YES		
CERTIFIED OPERATORS	NO	YES		
MIL LINE PROCESSING	YES	YES		
MAX REWORK SPECIFIED	NO	YES		
ENCAPSULANT	GEL COAT	GEL COAT		
PRE-CAP VISUAL	YES - INDUSTRIAL	YES - CLASS H		
TEMP CYCLE (-55°C TO +125°C)	NO	YES		
BURN-IN	NO	YES - 160 HOURS		
ELECTRICAL TESTING	YES - 25°C	YES - FULL TEMP		
EXTERNAL VISUAL	YES - SAMPLE	YES		
XRAY	NO	NO		
PIN FINISH	NI	NI		

NOTE: ADDITIONAL SCREENING IS AVAILABLE SUCH AS XRAY, CSAM, MECHANICAL SHOCK, ETC. CONTACT FACTORY FOR QUAL STATUS.

MECHANICAL SPECIFICATIONS



FOR CONVEX BASEPLATE PROFILE SEE SHEET 7

MECHANICAL SPECIFICATIONS CONT'D



ORDERING INFORMATION

<u>MSK4854 H</u>

SCREENING

BLANK = INDUSTRIAL; H = HI-REL (MODIFIED 38534) GENERAL PART NUMBER

THE ABOVE EXAMPLE IS A HI-REL SCREENED MODULE.

REVISION HISTORY

REV	STATUS	DATE	DESCRIPTION
Е	Released	05/14	Update electrical specifications, mechanical outline, add performance curves and new form number.

M.S. Kennedy Corp. Phone (315) 701-6751 FAX (315) 701-6752 www.mskennedy.com

The information contained herein is believed to be accurate at the time of printing. MSK reserves the right to make changes to its products or specifications without notice, however, and assumes no liability for the use of its products. Please visit our website for the most recent revision of this datasheet.